## Application/Control No. Applicant(s)/Patent Under Reexamination 10/796,470 SHIH ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Edna Wong 1753 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-2004/0168928 09-2004 Hardikar, Vishwas Α 205/296 US-2004/0249177 12-2004 В Wang et al. 549/563 С US-D US-US-Ε US-F G USн US-USı US-US-K US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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